

Figure 1. Simplified process flow in RMG

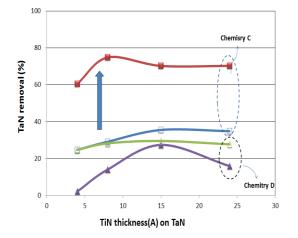


Figure 3. RIE effects on TaN removal rate in TiN/TaN stack

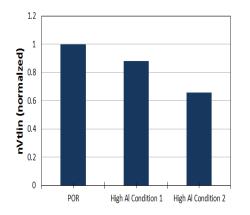


Figure 5. Normalized nVth with diferent nWF process.

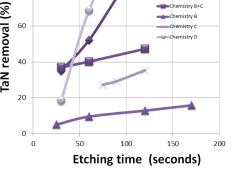


Figure 2. TaN removal by different etch chemistry

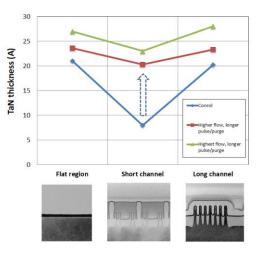


Figure 4. TaN loading effects on different macros

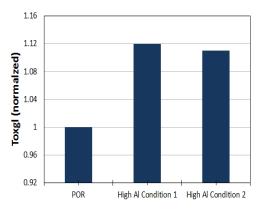


Figure. 6. Normalize Toxgl gain from different nWF process.